

Effect of thermal aging on the corrosion behaviors of ER316L stainless steel welds in simulated PWR environments

2019.5.24

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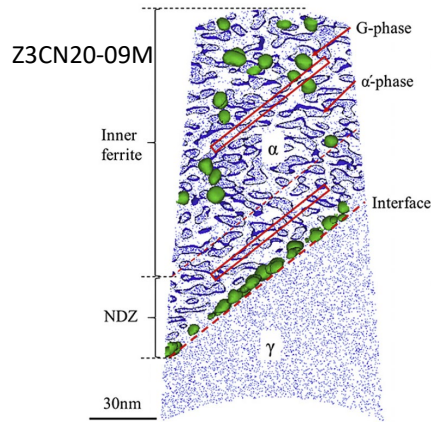
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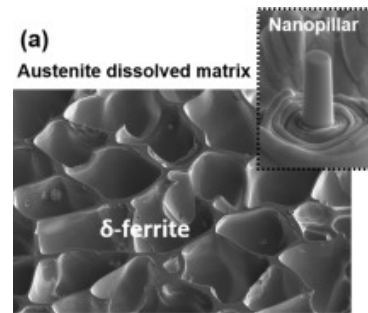
Introduction

Thermal aging in LWRs systems

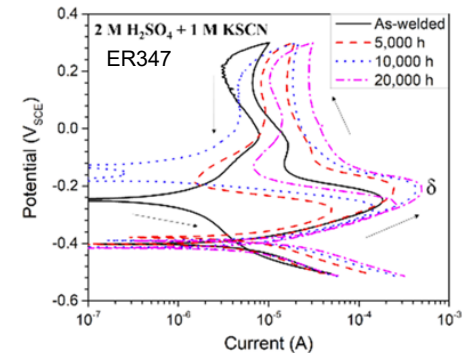
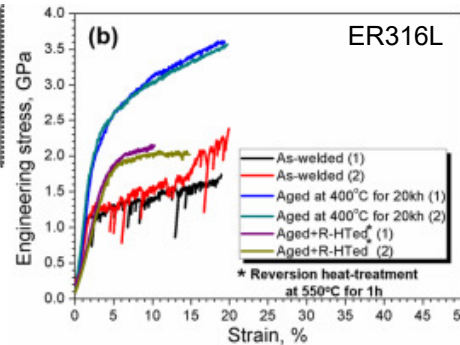
- Austenitic stainless steel (SS) welds and duplex stainless steel (DSS) in LWRs
 - cast primary coolant circuit pipes, safety-ends of the pressure vessels, cases of main pumps, weld joints and weld overlays
 - 5-20% δ ferrite for preventing hot cracking
- Thermal aging effect
 - Developed under 450 °C during long-term service
 - Microstructure evolution: spinodal decomposition, G-phase, Ni-depletion, etc.
 - Degradation of materials properties: corrosion resistance, mechanical properties, etc.



Acta Mater. 140 (2017) 388



Scripta Mater. 155 (2018) 32



SCI REP-UK, 15091(2018)

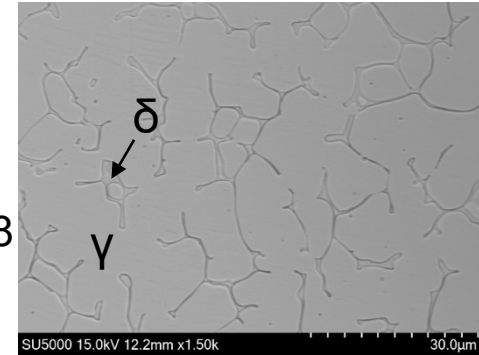
Objective

- Corrosion behaviors of as-welded and thermal aged ER316L SS welds in simulated PWR primary water environment

Experimental

Materials

- As-welded ER316L SS weld metal (GTAW)
- Thermal aged 10 kh @ 400 °C ER316L SS weld metal
- Composition (wt%):
 - Bulk: Fe Bal., Cr 18.4, Ni 11.0, Mo 2.6, Mn 1.7, Si 0.4, C 0.008
 - γ austenite phase : Fe 70.2, Cr 18.5, Ni 10.0 (TEM)
 - δ ferrite phase: Fe 68.1, Cr 28.4, Ni 2.4 (TEM)
 - Ferrite content (vol.%): 12.3 ± 1.3
- Pre-exposure preparation
 - 600# to 7000# SiC grinding → 1 μ m diamond paste polishing → 0.06 μ m Alumina suspension polishing



Simulated PWR primary water exposure

- B: 1200 ppm (H_3BO_3), Li: 2.2 ppm (LiOH), flow rate: ~3 L/h, pressure: 13 MPa, T@325 °C
- DO < 5 ppb, DH = 30 ml/kg water STP
- Exposure time: 500 h

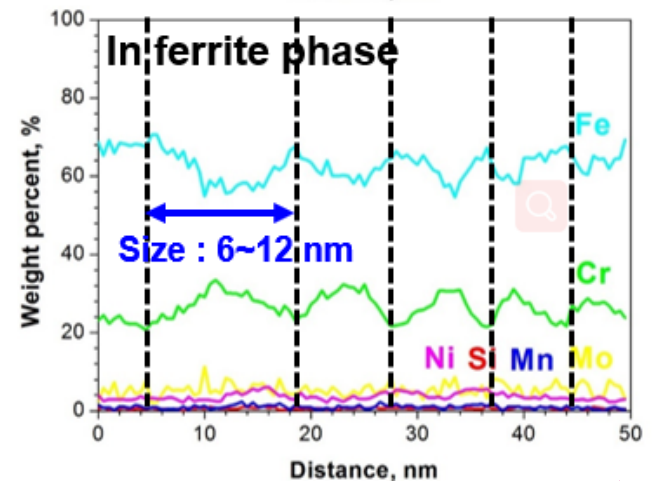
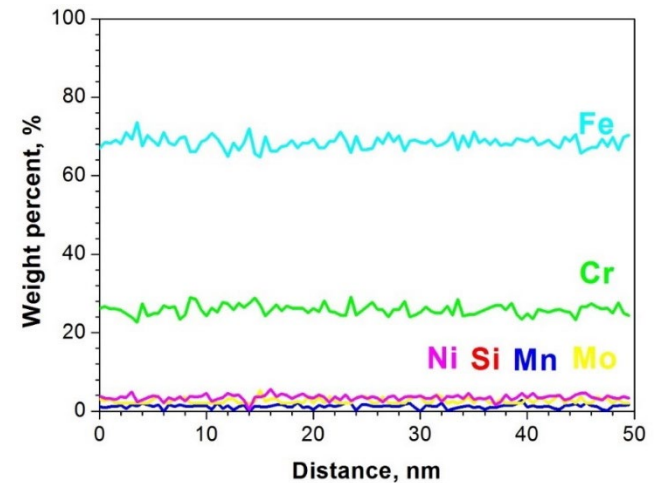
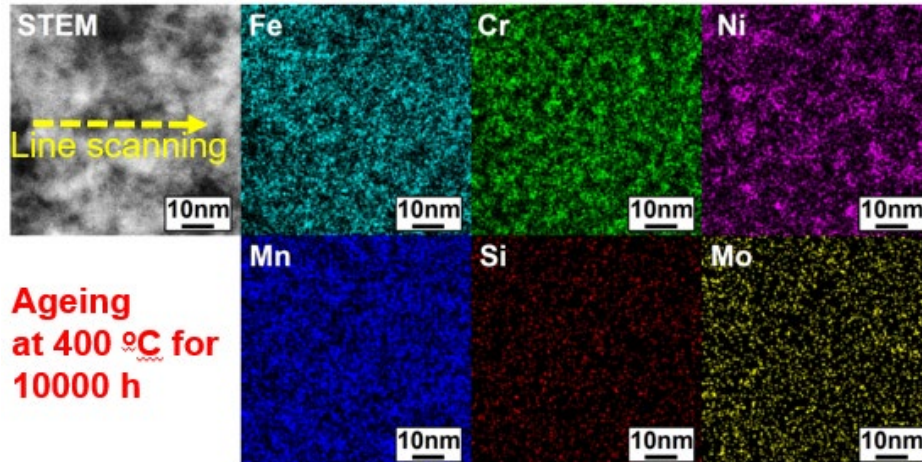
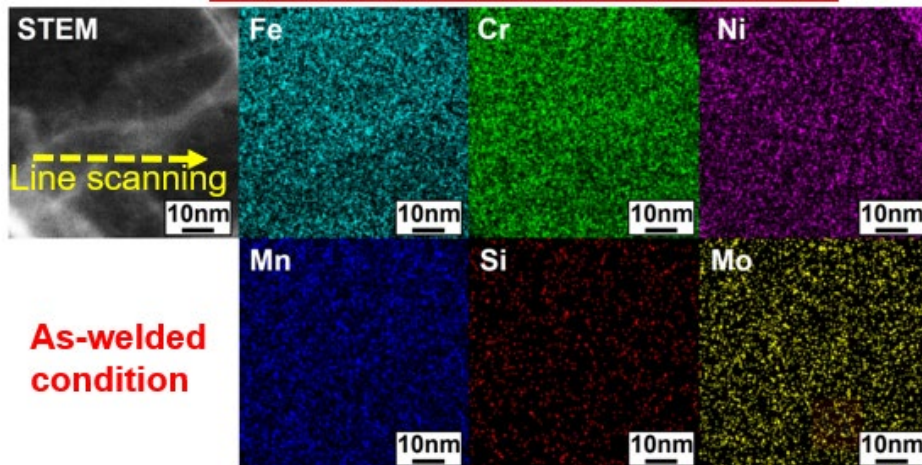
Microstructure analysis

- SEM: Hitachi SU5000
- FIB: FEI Helios G4 UX
- TEM: FEI Talos F200X
- Mott-Schottky: -0.6 V(SCE) to 0.6V(SCE), @RT, buffer solution

Results

Microstructure before exposure (δ ferrite) — TEM-EDS

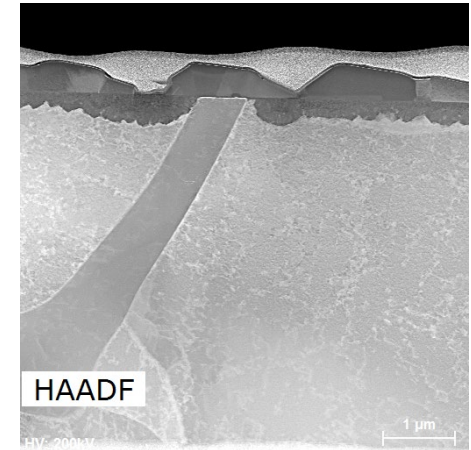
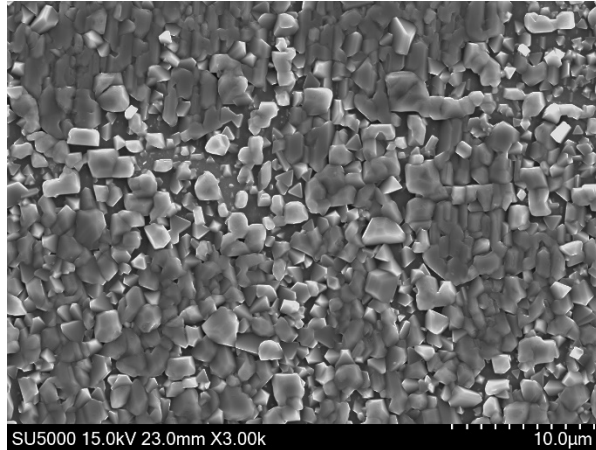
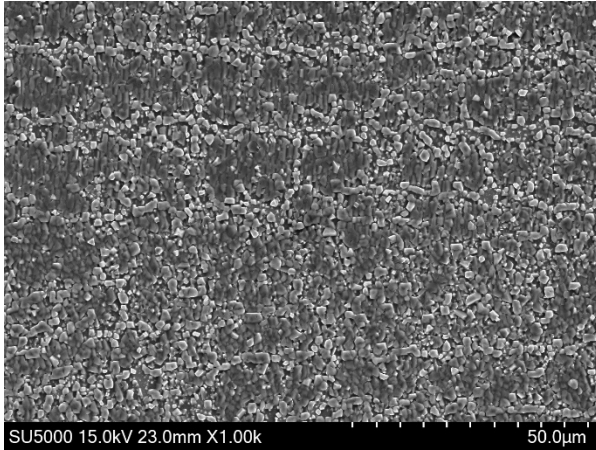
- As-welded: no obvious element fluctuation and G phase
- Thermal aged 10 kh @ 400 °C :
 - Significant element fluctuation — spinodal decomposition
 - No significant G phase



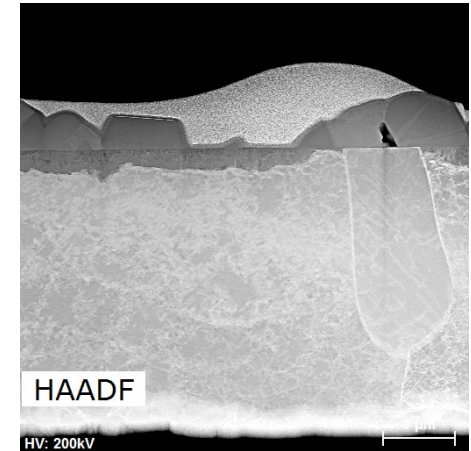
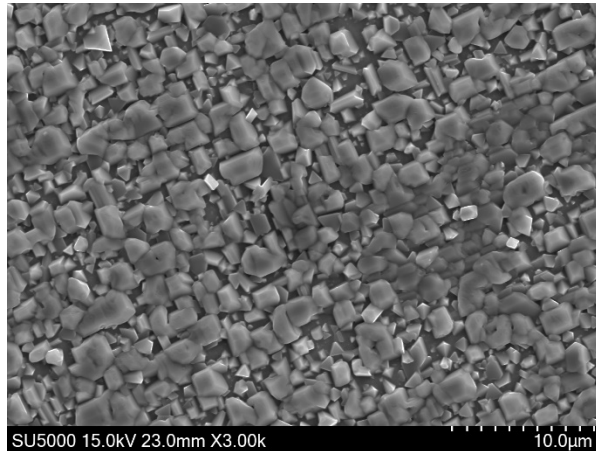
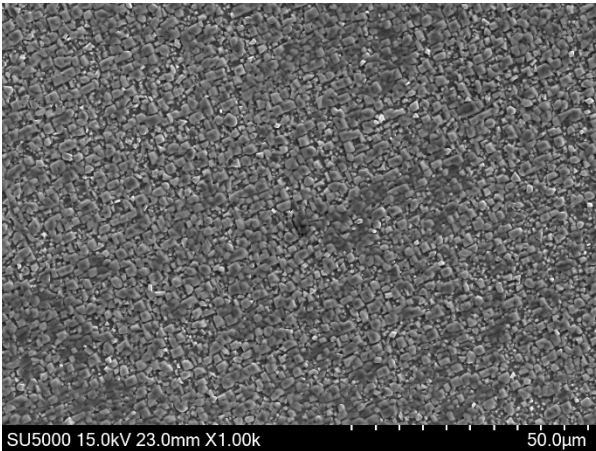
Results

□ Oxide films analysis after exposure——SEM/TEM

- Duplex structural oxide films



As-welded ER 316L

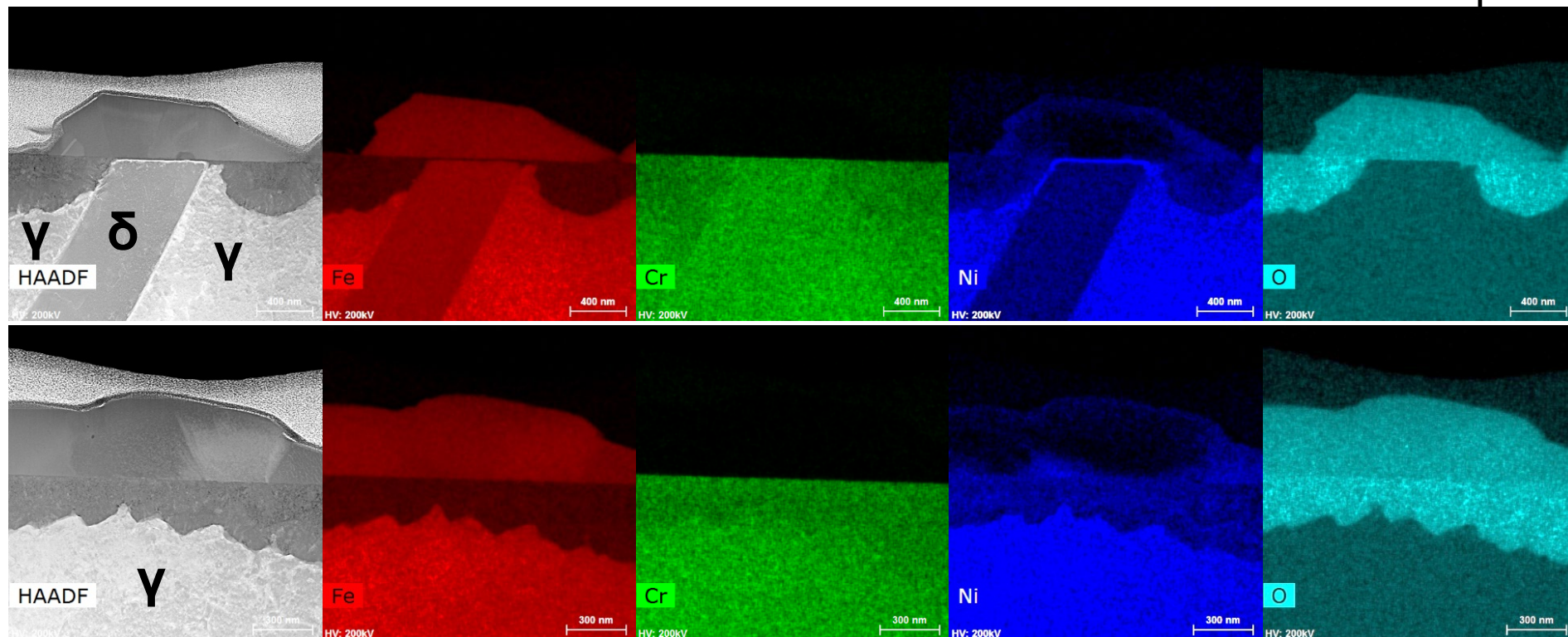


Thermal aged 10 kh ER 316L

Results

□ Oxide films on as-welded ER316L—TEM-EDS

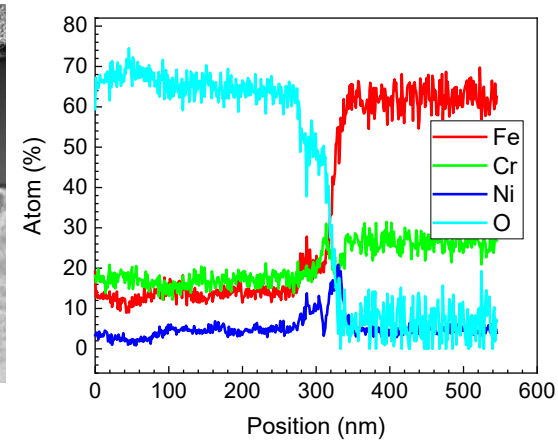
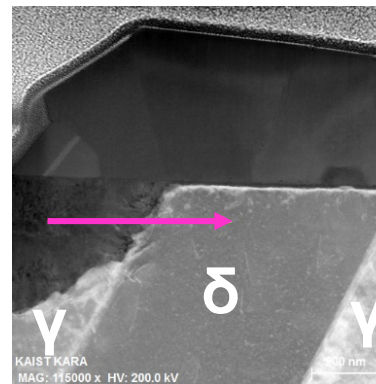
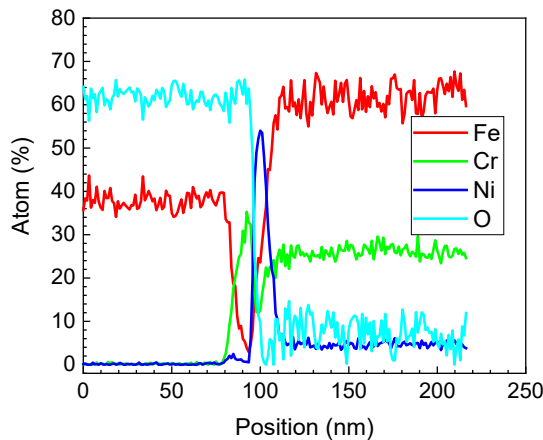
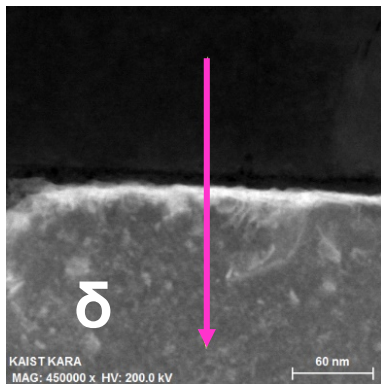
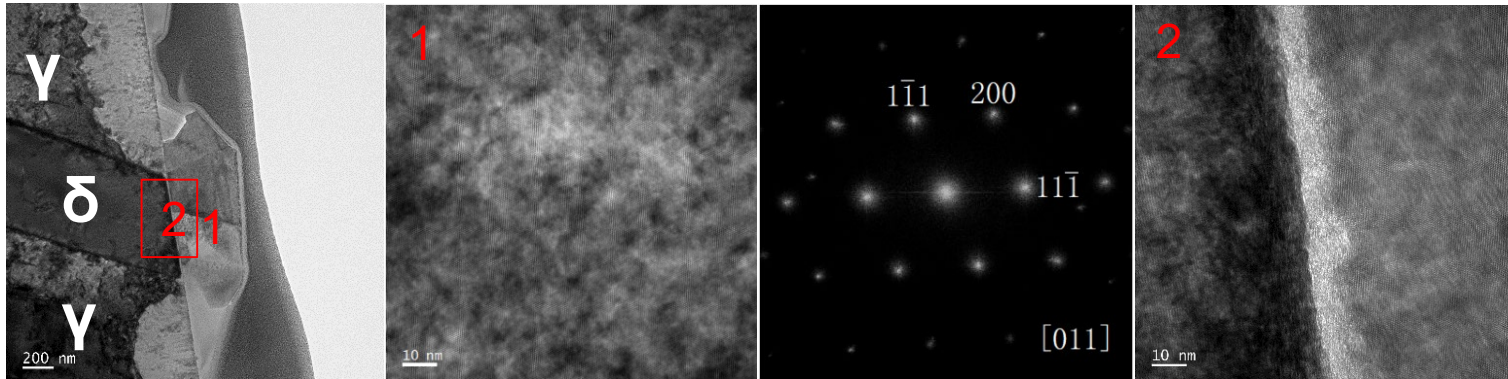
- Duplex structural oxide film
 - Outer big oxide particles on δ & γ phases: Fe-rich
 - Inner oxide films on δ phase: Cr-rich
 - Inner oxide films on γ phase: Fe, Cr, Ni
 - Ni enrichment in δ matrix beneath the δ /inner film interface
 - Ni enrichment in δ matrix close to the interface of δ /inner film on γ



Results

□ Oxide films on as-welded ER316L—TEM-EDS

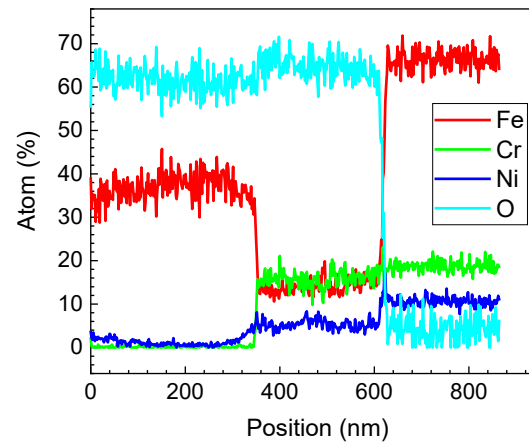
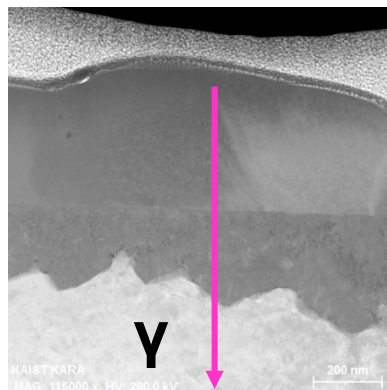
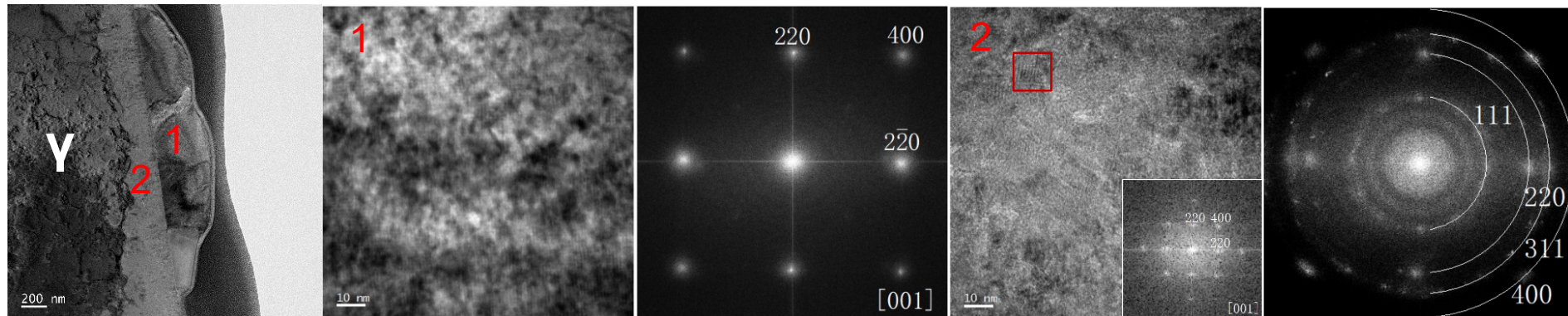
- Duplex structural oxide film on δ phase
 - Outer spinel-type Fe-rich oxide particle
 - Inner Cr-rich amorphous thin oxide film
 - Ni enrichment in δ matrix beneath the δ /inner film interface
 - Ni enrichment in δ matrix close to the interface of δ /inner film on γ



Results

□ Oxide films on as-welded ER316L——TEM-EDS

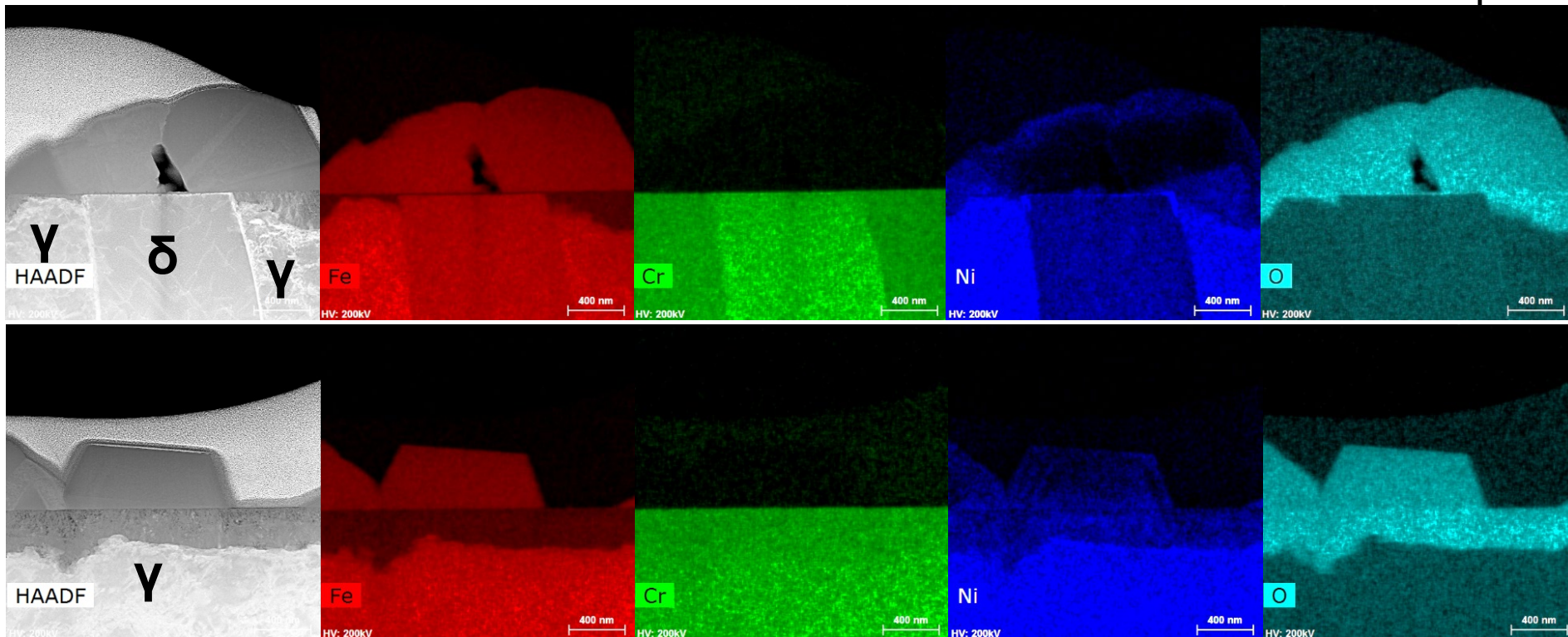
- Duplex structural oxide film on γ phase
 - Outer spinel-type Fe-rich oxide particle
 - Inner Fe & Cr-rich spinel-type nanocrystalline/amorphous oxide film



Results

□ Oxide films on thermal aged 10 kh ER316L——TEM-EDS

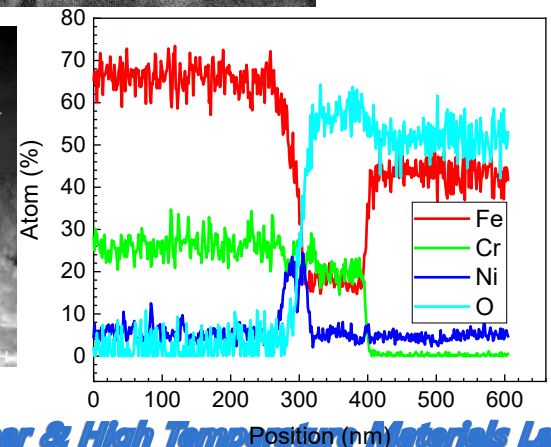
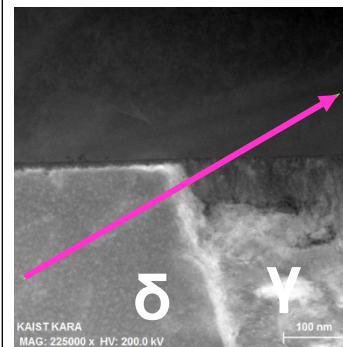
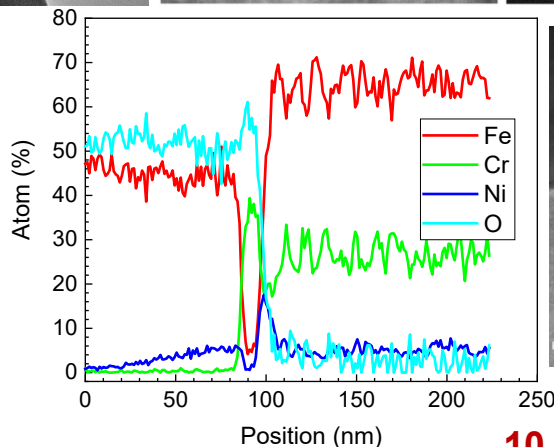
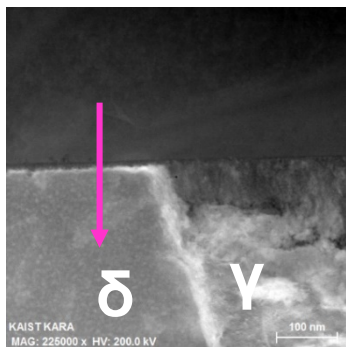
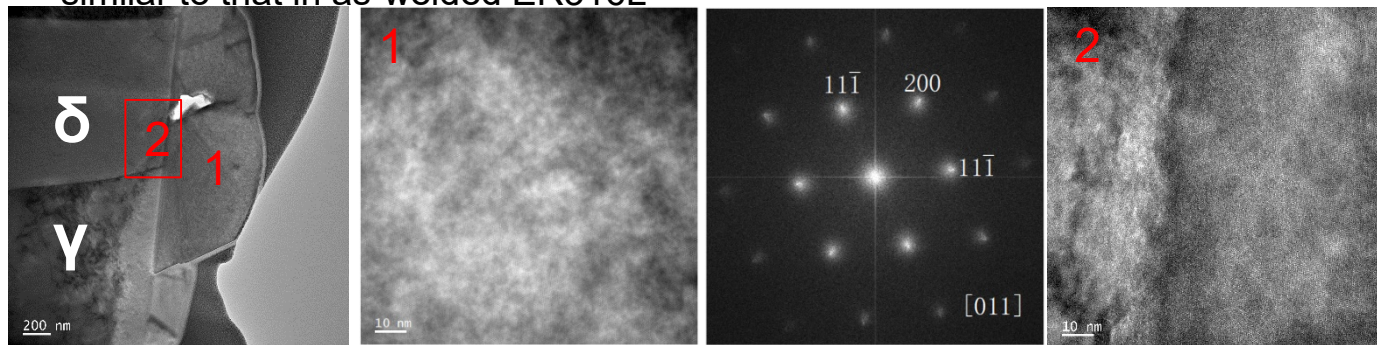
- Duplex structural oxide film
 - Outer big oxide particles on δ & γ phases: Fe-rich
 - Inner oxide films on δ phase: Cr-rich
 - Inner oxide films on γ phase: Fe, Cr, Ni
 - Ni enrichment in δ matrix beneath the δ /inner film interface
 - Ni enrichment in δ matrix close to the interface of δ /inner film on γ



Results

□ Oxide films on thermal aged 10 kh ER316L—TEM-EDS

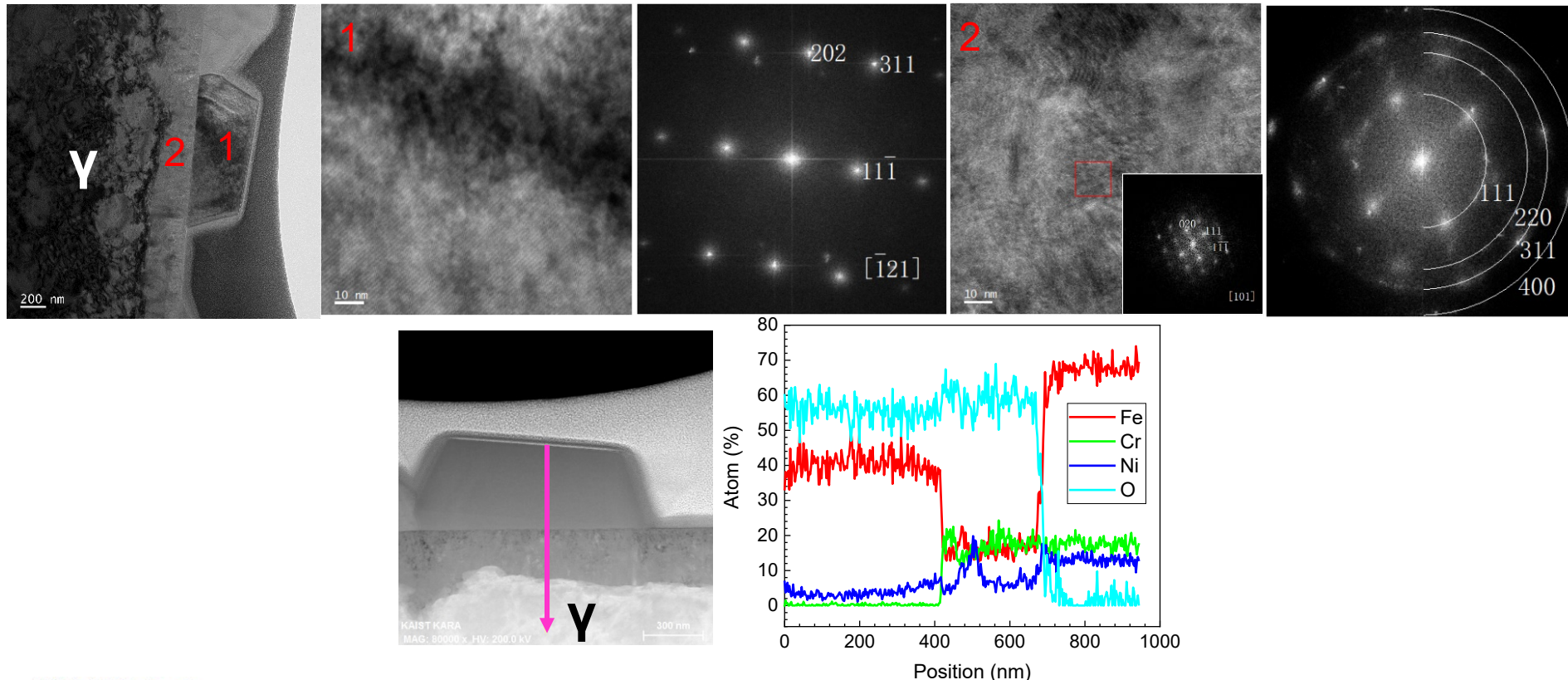
- Duplex structural oxide film on δ phase
 - Outer spinel-type Fe-rich oxide particle
 - slightly higher Ni content than as-welded ER316L
 - Inner Cr-rich amorphous thin oxide film
 - Ni enrichment in δ matrix beneath the δ /inner film interface
 - less than that in as-welded ER316L
 - Ni enrichment in δ matrix close to the interface of δ /inner film on γ
 - similar to that in as-welded ER316L



Results

□ Oxide films on thermal aged 10 kh ER316L—TEM-EDS

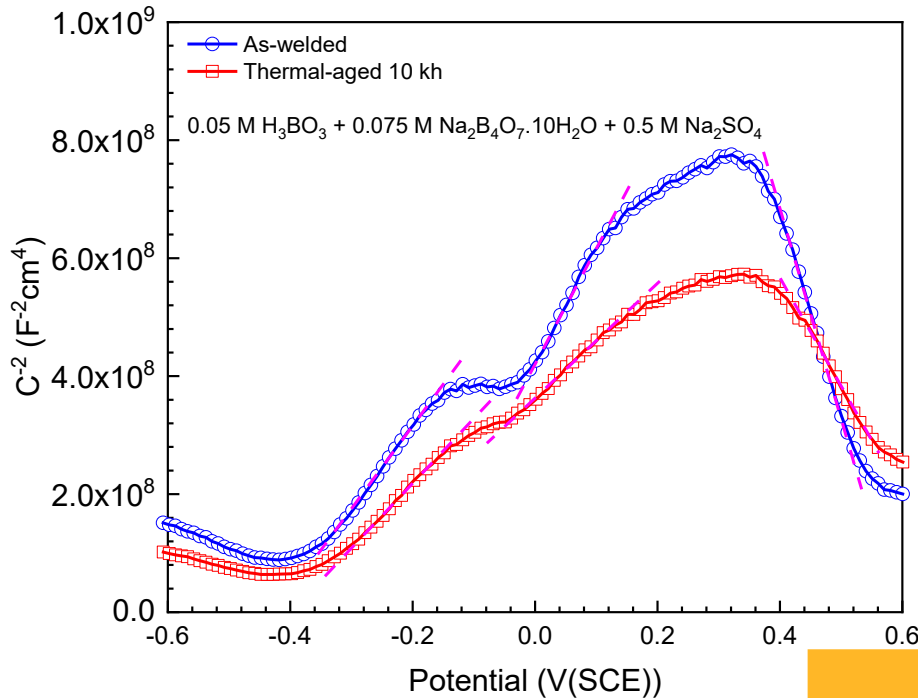
- Duplex structural oxide film on γ phase
 - Outer spinel-type Fe-rich oxide particle
 - slightly higher Ni content than as-welded ER 316L
 - Inner Fe & Cr-rich spinel-type nanocrystalline/amorphous oxide film



Results

□ Mott-Schottky analysis — point defect density in oxides

- Higher point defect (donor or acceptor) densities in oxides on thermal aged 10 kh ER316L
 - p-type oxides: chromia, n-type oxides: spinel
 - In matrix: $D_{Cr} > D_{Fe} > D_{Ni}$
 - In oxides (D): $Fe^{2+} > Ni^{2+} \gg Cr^{3+}$



For the n-type semiconductor

$$\frac{1}{C_{SC}^2} = \left(\frac{2}{\epsilon \epsilon_0 e N_D} \right) \left(U - U_{FB} - \frac{kT}{e} \right)$$

For the p-type semiconductor

$$\frac{1}{C_{SC}^2} = - \left(\frac{2}{\epsilon \epsilon_0 e N_A} \right) \left(U - U_{FB} + \frac{kT}{e} \right)$$

- N_A Acceptor density
- N_D Donor density
- ϵ Dielectric constant of oxides
- ϵ_0 Vacuum permittivity
- e Electron charge
- k Boltzmann constant
- T Absolute temperature
- U Applied potential
- U_{FB} Flat band potential

	Region I N_D (10^{20} cm^{-3})	Region II N_D (10^{20} cm^{-3})	Region III N_A (10^{20} cm^{-3})
As-welded	47.5	33.4	30.9
Thermal aged	68.9	73.4	57.9

Summary

□ Microstructure after thermal ageing

- As-welded ER316L: no obvious element fluctuation and G phase
- Thermal aged 10 kh @ 400 °C ER316L:
 - Significant element fluctuation—— spinodal decomposition
 - No significant G phase

□ Corrosion behaviors in PWR environment

- Duplex structural oxide films formed on as-welded and thermal aged ER316L:
 - Outer spinel-type oxide particles
 - as-welded: Fe-rich, Ni & Cr-depleted
 - thermal-aged: Fe-rich, with slightly higher Ni content
 - Inter oxide film on γ austenite phase
 - nanocrystalline/amorphous spinel-type oxide film
 - Inter oxide film on δ ferrite phase
 - Cr-rich amorphous thin oxide film
 - Higher point defect densities in oxide films of thermal aged ER316L
 - as-welded: higher Ni enrichment in δ matrix beneath the δ /inner film interface
 - thermal-aged: slightly higher Ni content in the outer oxide films

□ Future work

- High resolution observation of oxide film/matrix interface on δ ferrite
- Water chemistry effect

Energy for Earth !!



Thank you!